# **Power MOSFET**

# 30 V, 117 A, Single N-Channel, DPAK/IPAK

#### **Features**

- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- AEC Q101 Qualified NVD4804N
- These Devices are Pb-Free and are RoHS Compliant

# **Applications**

- CPU Power Delivery
- DC-DC Converters
- Low Side Switching

# **MAXIMUM RATINGS** (T<sub>J</sub> = 25°C unless otherwise noted)

Param	Parameter			Value	Unit
Drain-to-Source Voltage	e		$V_{DSS}$	30	V
Gate-to-Source Voltag	е		$V_{GS}$	±20	V
Continuous Drain		T <sub>A</sub> = 25°C	I <sub>D</sub>	19.6	Α
Current (R <sub>θJA</sub> ) (Note 1)		T <sub>A</sub> = 85°C		15.2	
Power Dissipation (R <sub>θJA</sub> ) (Note 1)		T <sub>A</sub> = 25°C	P <sub>D</sub>	2.66	W
Continuous Drain		T <sub>A</sub> = 25°C	I <sub>D</sub>	14.5	Α
Current (R <sub>θJA</sub> ) (Note 2)	Steady	T <sub>A</sub> = 85°C		11	
Power Dissipation (R <sub>θJA</sub> ) (Note 2)	State	T <sub>A</sub> = 25°C	P <sub>D</sub>	1.43	W
Continuous Drain		T <sub>C</sub> = 25°C	I <sub>D</sub>	124	Α
Current (R <sub>0JC</sub> ) (Note 1)		T <sub>C</sub> = 85°C		96	
Power Dissipation (R <sub>θJC</sub> ) (Note 1)		T <sub>C</sub> = 25°C	P <sub>D</sub>	107	W
Pulsed Drain Current	t <sub>p</sub> =10μs	T <sub>A</sub> = 25°C	I <sub>DM</sub>	230	Α
Current Limited by Pack	age	T <sub>A</sub> = 25°C	I <sub>DmaxPkg</sub>	45	Α
Operating Junction and	Storage Te	emperature	T <sub>J</sub> , T <sub>stg</sub>	-55 to 175	°C
Source Current (Body D	iode)		IS	78	Α
Drain to Source dV/dt	dV/dt	6.0	V/ns		
Single Pulse Drain-to-S Energy ( $V_{DD}$ = 24 V, $V_{GS}$ L = 1.0 mH, $I_{L(pk)}$ = 30 A	$_{S} = 10 \text{ V},$		E <sub>AS</sub>	450	mJ
Lead Temperature for So (1/8" from case for 10 s)	Idering Pu	rposes	TL	260	°C

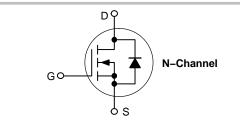
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.



# ON Semiconductor®

#### www.onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> MAX	I <sub>D</sub> MAX
30 V	4.0 mΩ @ 10 V	117 A
30 V	5.5 mΩ @ 4.5 V	117 A







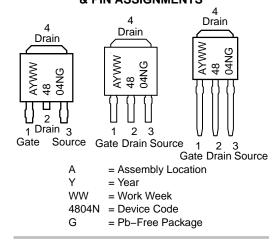


CASE 369AA **DPAK** (Bent Lead) STYLE 2

CASE 369AD 3 IPAK (Straight Lead) (Straight Lead

CASE 369D **IPAK** DPAK)

# **MARKING DIAGRAMS** & PIN ASSIGNMENTS



#### **ORDERING INFORMATION**

See detailed ordering and shipping information in the package dimensions section on page 6 of this data sheet.

# THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	1.4	°C/W
Junction-to-TAB (Drain)	$R_{\theta JC-TAB}$	3.5	
Junction-to-Ambient - Steady State (Note 1)	$R_{ heta JA}$	56.4	
Junction-to-Ambient - Steady State (Note 2)	$R_{ heta JA}$	105	

- Surface–mounted on FR4 board using 1 in sq pad size, 1 oz Cu.
   Surface–mounted on FR4 board using the minimum recommended pad size.

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS						•	
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>				26		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{GS} = 0 \text{ V}, \qquad T_{J} = 25^{\circ}\text{C}$				1.0	μΑ
		V <sub>DS</sub> = 24 V	T <sub>J</sub> = 125°C			10	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{GS}$	= ±20 V			±100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D =$	= 250 μΑ	1.5		2.5	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				7.6		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 to 11.5 V	I <sub>D</sub> = 30 A		3.4	4.0	mΩ
			I <sub>D</sub> = 15 A		3.4		
		V <sub>GS</sub> = 4.5 V	I <sub>D</sub> = 30 A		4.7	5.5	
			I <sub>D</sub> = 15 A		4.6		
Forward Transconductance	gFS	$V_{DS} = 15 \text{ V}, I_D = 15 \text{ A}$			23		S
CHARGES AND CAPACITANCES							
Input Capacitance	C <sub>iss</sub>	$V_{GS} = 0 \text{ V, f} = 1.0 \text{ MHz,}$ $V_{DS} = 12 \text{ V}$			4490		pF
Output Capacitance	C <sub>oss</sub>				952		7
Reverse Transfer Capacitance	C <sub>rss</sub>				556		
Total Gate Charge	$Q_{G(TOT)}$				30	40	nC
Threshold Gate Charge	Q <sub>G(TH)</sub>	$V_{GS} = 4.5 \text{ V}, V_{D}$	<sub>S</sub> = 15 V,		5.5		
Gate-to-Source Charge	$Q_{GS}$	I <sub>D</sub> = 30 /	A		13		
Gate-to-Drain Charge	$Q_{GD}$				13		
Total Gate Charge	$Q_{G(TOT)}$	$V_{GS} = 11.5 \text{ V}, V_{D}$ $I_{D} = 30 \text{ A}$			73		nC
SWITCHING CHARACTERISTICS (Note	e 4)						
Turn-On Delay Time	t <sub>d(on)</sub>				18		ns
Rise Time	t <sub>r</sub>	$V_{GS} = 4.5 \text{ V}, V_{D}$	<sub>S</sub> = 15 V,		20		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D = 15 \text{ A}, R_G = 3.0 \Omega$			24		
Fall Time	t <sub>f</sub>				8		1
Turn-On Delay Time	t <sub>d(on)</sub>				10		ns
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 11.5 V, V <sub>E</sub>	<sub>OS</sub> = 15 V,		19		1
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D = 15 \text{ A}, R_G = 3.0 \Omega$			35		1
Fall Time	t <sub>f</sub>				5		

- 3. Pulse Test: Pulse Width  $\leq$  300  $\mu$ s, Duty Cycle  $\leq$  2%.
- 4. Switching characteristics are independent of operating junction temperatures.

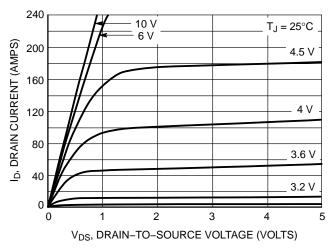
# **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
DRAIN-SOURCE DIODE CHARACT	ERISTICS	•					•
Forward Diode Voltage	V <sub>SD</sub>	$V_{GS} = 0 V$ ,	$T_J = 25^{\circ}C$		0.81	1.2	V
		I <sub>S</sub> = 30 A	T <sub>J</sub> = 125°C		0.72		1
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS} = 0 \text{ V, dls/dt} = 100 \text{ A/}\mu\text{s,}$ $I_{S} = 30 \text{ A}$			34		ns
Charge Time	ta				19		1
Discharge Time	tb				15		1
Reverse Recovery Time	$Q_{RR}$				30		nC
PACKAGE PARASITIC VALUES	•	•					•
Source Inductance	L <sub>S</sub>				2.49		nΗ
Drain Inductance, DPAK	L <sub>D</sub>	1			0.0164		1
Drain Inductance, IPAK	L <sub>D</sub>	$T_A = 1$	T <sub>A</sub> = 25°C		1.88		1
Gate Inductance	L <sub>G</sub>	1			3.46		1
Gate Resistance	R <sub>G</sub>	1			0.6		Ω

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

# **TYPICAL PERFORMANCE CURVES**

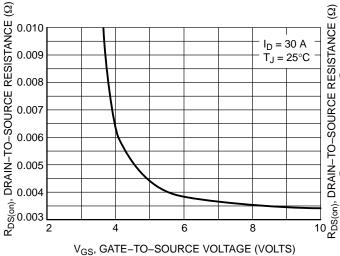
240



 $\widehat{Q}_{AB}$  200  $\widehat{Q}_{AB}$  160  $\widehat{Q}_{AB}$  120  $\widehat{Q}_{AB}$  120  $\widehat{Q}_{AB}$  80  $\widehat{Q}_{AB}$  120  $\widehat{Q}_{AB}$  40  $\widehat{Q}_{AB}$  125°C  $\widehat{Q}_{AB}$  7  $\widehat{Q}_{AB}$  40  $\widehat{Q}_{AB}$  50  $\widehat{Q}_{AB}$  50  $\widehat{Q}_{AB}$  70  $\widehat{Q}_{AB}$  50  $\widehat{Q}_{AB}$  70  $\widehat{Q}_{AB}$  7

Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



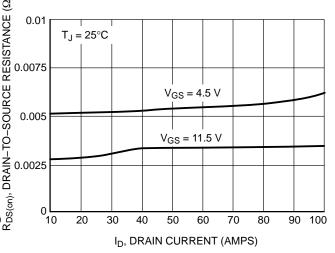
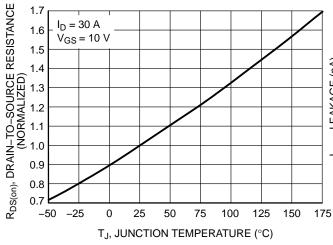


Figure 3. On–Resistance vs. Gate–to–Source Voltage

Figure 4. On–Resistance vs. Drain Current and Gate Voltage



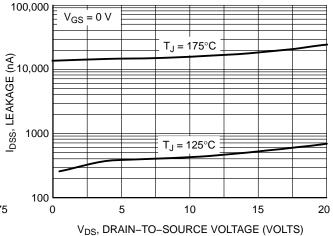
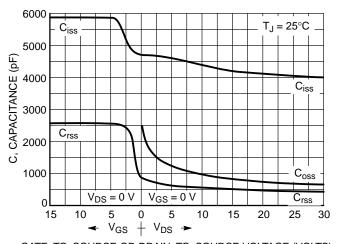


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Drain Voltage

#### **TYPICAL PERFORMANCE CURVES**



GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (VOLTS)

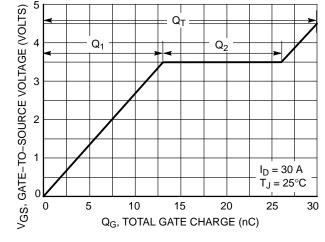


Figure 8. Gate-To-Source and Drain-To-Source Voltage vs. Total Charge



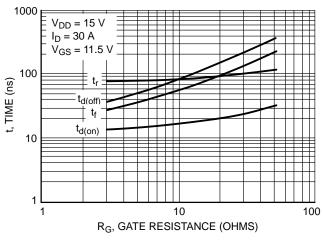


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

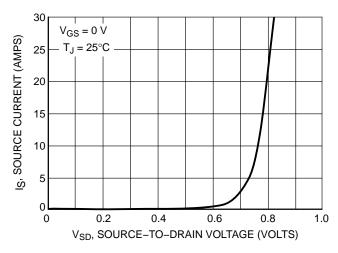


Figure 10. Diode Forward Voltage vs. Current

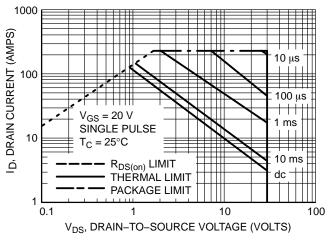


Figure 11. Maximum Rated Forward Biased Safe Operating Area

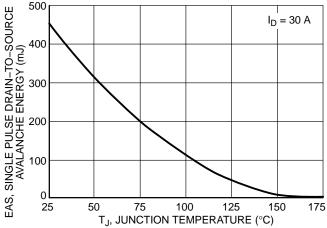


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

# **TYPICAL PERFORMANCE CURVES**

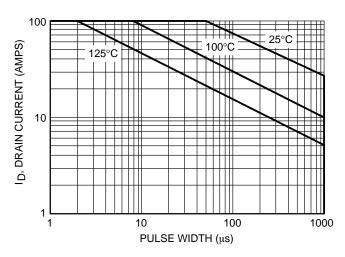


Figure 13. Avalanche Characteristics

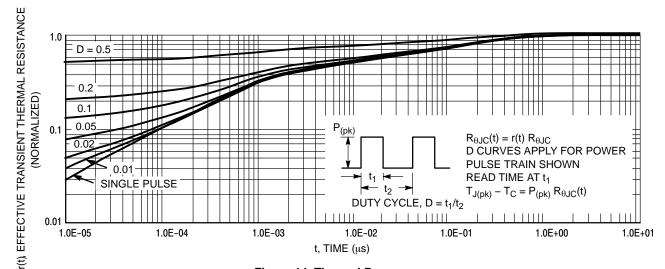


Figure 14. Thermal Response

# **ORDERING INFORMATION**

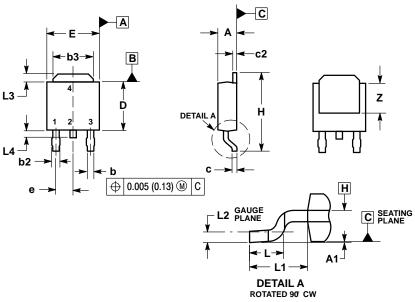
Order Number	Package	Shipping <sup>†</sup>
NTD4804NT4G	DPAK (Pb-Free)	2500 / Tape & Reel
NTD4804N-35G	IPAK Trimmed Lead (3.5 ± 0.15 mm) (Pb-Free)	75 Units / Rail
NVD4804NT4G	DPAK (Pb-Free)	2500 / Tape & Reel
NVD4804NT4G-VF01	DPAK (Pb-Free)	2500 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### PACKAGE DIMENSIONS

# **DPAK (SINGLE GUAGE)**

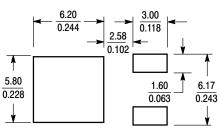
CASE 369AA **ISSUE B** 



- NOTES:
  1. DIMENSIONING AND TOLERANCING PER ASME
- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
  2. CONTROLLING DIMENSION: INCHES.
  3. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS b3, L3 and Z.
  4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE.
  5. DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
  6. DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.
- PLANE H.

	INCHES		MILLIM	ETERS
DIM	MIN	MAX	MIN	MAX
Α	0.086	0.094	2.18	2.38
A1	0.000	0.005	0.00	0.13
b	0.025	0.035	0.63	0.89
b2	0.030	0.045	0.76	1.14
b3	0.180	0.215	4.57	5.46
С	0.018	0.024	0.46	0.61
c2	0.018	0.024	0.46	0.61
D	0.235	0.245	5.97	6.22
E	0.250	0.265	6.35	6.73
е	0.090 BSC		2.29	BSC
н	0.370	0.410	9.40	10.41
L	0.055	0.070	1.40	1.78
L1	0.108	REF	2.74 REF	
L2	0.020	BSC	0.51	BSC
L3	0.035	0.050	0.89	1.27
L4		0.040		1.01
Z	0.155		3.93	

# **SOLDERING FOOTPRINT\***



 $\left(\frac{\text{mm}}{\text{inches}}\right)$ SCALE 3:1

STYLE 2:

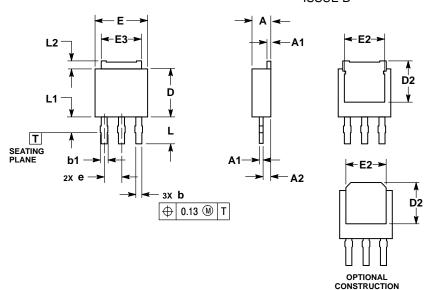
PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN

<sup>\*</sup>For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

#### PACKAGE DIMENSIONS

# 3.5 MM IPAK, STRAIGHT LEAD

CASE 369AD ISSUE B

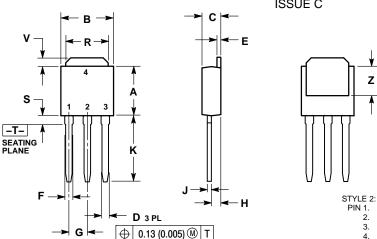


#### NOTES

- DIMENSIONING AND TOLERANCING PER
  ASME Y14.5M, 1994.
- CONTROLLING DIMENSION: MILLIMETERS.
   DIMENSION & APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.15 AND
- 0.30mm FROM TERMINAL TIP.
   DIMENSIONS D AND E DO NOT INCLUDE MOLD GATE OR MOLD FLASH.

	MILLIMETERS					
DIM	MIN	MAX				
Α	2.19	2.38				
A1	0.46	0.60				
A2	0.87	1.10				
b	0.69	0.89				
b1	0.77	1.10				
D	5.97	6.22				
D2	4.80					
E	6.35	6.73				
E2	4.57	5.45				
E3	4.45	5.46				
е	2.28	2.28 BSC				
L	3.40	3.60				
L1		2.10				
L2	0.89	1.27				

# IPAK CASE 369D ISSUE C



#### NOTES:

GATE

DRAIN

DRAIN

SOURCE

- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M. 1982.
- 2. CONTROLLING DIMENSION: INCH.

	INC	HES	MILLIM	ETERS
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.35
В	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
Е	0.018	0.023	0.46	0.58
F	0.037	0.045	0.94	1.14
G	0.090	BSC	2.29	BSC
Н	0.034	0.040	0.87	1.01
7	0.018	0.023	0.46	0.58
K	0.350	0.380	8.89	9.65
R	0.180	0.215	4.45	5.45
s	0.025	0.040	0.63	1.01
٧	0.035	0.050	0.89	1.27
Z	0.155		3.93	

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